CONTROL CHARTS FOR TWO VERSIONS OF THE TWO-PARAMETER LINDLEY DISTRIBUTION

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Two-parameter Lindley Distribution

 Lindley distribution first proposed by Lindley (1958)

Asymmetric continuous probability distribution

• Many applications in medical and actuarial science, biology, genetics, ecology and environmental monitoring, sociology and demography, engineering, life testing, reliability and stress-strength investigation etc.

- Many generalizations and mixtures of the Lindley distribution in the literature
- First version of the two-parameter Lindley distribution proposed by Shanker et al. (2013)

 Second version of the two-parameter Lindley distribution proposed by Shanker and Mishra (2013)





Fig. 1: Probability density function of the first two-parameter Lindley distribution for various values of the parameters

• p.d.f.:
$$f_X(x) = \frac{\theta^2}{\theta + r} (1 + rx) e^{-\theta x}, x > 0, \theta > 0, r > -\theta$$

• mean:
$$E(X) = \frac{\theta + 2r}{\theta(\theta + r)}$$

• variance:
$$V(X) = \frac{\theta^2 + 4\theta r + 2r^2}{\theta^2 (\theta + r)^2}$$

Skewness Correction

• skewness correction for the mean:

$$c_{4}^{*}(\bar{x}) = \frac{\frac{4}{3}[sk(\bar{x})]}{1+0.2[sk(\bar{x})]^{2}} \quad sk(\bar{x}) = sk(\frac{X}{\sqrt{n}}) = \frac{2(\theta^{3}+6\theta^{2}r+6\theta r^{2}+2r^{3})}{(\theta^{2}+4\theta r+2r^{2})^{3/2}\sqrt{n}}$$

• skewness correction for $\frac{4}{2}[sk(s^2)]$ the variability: $c_4^*(s^2)$ = $\frac{1+0.2[sk(s^2)]^2}{1+0.2[sk(s^2)]^2}$

$$sk(s^{2}) = \frac{\left[\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2}(\theta + r)^{2}} - n\left(\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2}(\theta + r)^{2}}\right)^{2}\right]^{3/2}}{(n-1)\left[\frac{1}{n}\left\{E\left(X - \mu\right)^{4} - \frac{n-3}{n-1}\left(\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2}(\theta + r)^{2}}\right)^{2}\right\}\right]^{3/2}}$$

Shewhart-type 1st Two-parameter Lindley Control Charts for Detecting Shifts in The Process Mean

$$UCL = \frac{\theta + 2r}{\theta(\theta + r)} + [L + c_4^*(\bar{x})] \sqrt{\frac{\theta + 4\theta r + 2r^2}{n\theta^2(\theta + r)^2}}$$

$$CL = \frac{\theta + 2r}{\theta(\theta + r)}$$

$$LCL = \frac{\theta + 2r}{\theta(\theta + r)} + \left[-L + c_4^*\left(\bar{x}\right)\right] \sqrt{\frac{\theta + 4\theta r + 2r^2}{n\theta^2(\theta + r)^2}}$$

Shewhart-type 1st Two-parameter Lindley Control Charts for Detecting **Shifts in The Process Variability**

$$UCL = \frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2} (\theta + r)^{2}} + \left[L + c_{4}^{*}(s^{2})\right] \sqrt{(n-1)\left[\frac{1}{n}\left[E(X-\mu)^{4} - \frac{n-3}{n-1}\left(\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2} (\theta + r)^{2}}\right)^{2}\right]^{3/2}}$$

$$CL = \frac{\theta^2 + 4\theta r + 2r^2}{\theta^2 \left(\theta + r\right)^2}$$

$$LCL = \frac{\theta^2 + 4\theta r + 2r^2}{\theta^2 (\theta + r)^2} + \left[-L + c_4^* (s^2)\right] \sqrt{(n-1)\left[\frac{1}{n} \left\{E(X - \mu)^4 - \frac{n-3}{n-1}\left(\frac{\theta^2 + 4\theta r + 2r^2}{\theta^2 (\theta + r)^2}\right)^2\right\}\right]^{3/2}}$$

Fig. 4: Probability density function of the 1st two-parameter Lindley(56,68) and the Lomax(4.98) distribution

in θ or in r



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Example of Control Charts for the 1st **Two-parameter Lindley Distribution**

- simulated data (30 samples of 5 observations) • data from a 1st two-parameter Lindley distribution with θ = 56 and r = 68 (15 samples of 5 observations)
- a change in the process mean of 1σ (15 samples of 5 observations) due to a shift either







Fig. 3: Shewhart-type control chart for the process variability for a change in θ

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Fig. 5: Shewhart-type control chart for the mean of a process with control limits based on a 1st twoparameter Lindlev(56.68) distribution and plotted data from a Lomax(4,98) distribution



Parameter Estimation

- solve equation $(2-k)b^2 + 4(2-k)b + 2(3-2k) = 0$
- k estimated using first and second sample moments about origin: $k = \frac{m_2^2}{\bar{v}^2}$





 control limits constructed by replacing θ and r with their estimators

Real Data Example

Waiting times [Ghitany et al. (2008), Shanker et al. (2013)]





Fig. 8: Shewhart-type control chart for the process variability

CONTROL CHARTS FOR TWO VERSIONS OF THE TWO-PARAMETER LINDLEY DISTRIBUTION

(continued)

First Version of the Two-parameter Lindley Distribution



Fig. 9: Probability density function of the 2nd two-parameter Lindley distribution for various values of the parameters

• p.d.f.:
$$f_X(x) = \frac{\theta^2}{r\theta + 1}(r + x)e^{-\theta x}, x > 0, \theta > 0, r\theta > -1$$

• mean: E(X) =

• variance: $V(X) = \frac{r^2 \theta^2 + 4r \theta + 2}{r^2 \theta^2 + 4r \theta + 2}$ $\theta (r\theta + 1)^2$

Skewness Correction

skewness correction for the mean:

$$c_{4}^{*}(\bar{x}) = \frac{\frac{4}{3}[sk(\bar{x})]}{1+0.2[sk(\bar{x})]^{2}} \quad sk(\bar{x}) = sk(\frac{X}{\sqrt{n}}) = \frac{2(r^{3}\theta^{3}+6r^{2}\theta^{2}+6r\theta+2)}{(r^{2}\theta^{2}+4r\theta+2)^{3/2}\sqrt{n}}$$

• skewness correction for the variability: $c_4^*(s^2) = \frac{1}{2}$ $1+0.2[sk(s^2)]^2$

$$sk(s^{2}) = \frac{\left[\frac{r^{2}\theta^{2} + 4r\theta + 2}{\theta^{2}(r\theta + 1)^{2}} - n\left(\frac{r^{2}\theta^{2} + 4r\theta + 2}{\theta^{2}(r\theta + 1)^{2}}\right)^{2}\right]^{3/2}}{(n-1)\left[\frac{1}{n}\left\{E\left(X-\mu\right)^{4} - \frac{n-3}{n-1}\left(\frac{r^{2}\theta^{2} + 42\theta + 2}{\theta^{2}(r\theta + 1)^{2}}\right)^{2}\right\}\right]^{3/2}}$$

Shewhart-type 2nd Two-parameter Lindley Control Charts for Detecting Shifts in The Process Mean

$$UCL = \frac{r\theta + 2}{\theta(r\theta + 1)} + \left[L + c_4^*(\bar{x})\right] \sqrt{\frac{r^2\theta + 4r\theta + 2r\theta}{n\theta^2(r\theta + 1)}}$$

$$CL = \frac{r\theta + 2}{\theta \left(r\theta + 1 \right)}$$

$$LCL = \frac{r\theta + 2}{\theta(r\theta + 1)} + \left[-L + c_4^*\left(\bar{x}\right)\right] \sqrt{\frac{r^2\theta + 4r\theta + 2}{n\theta^2(r\theta + 1)^2}}$$

Shewhart-type 2nd Two-parameter Lindley Control Charts for Detecting Shifts in The Process Variability

$$UCL = \frac{r^{2}\theta^{2} + 4r\theta + 2}{\theta(r\theta + 1)^{2}} + [L + c_{4}^{*}(s^{2})]\sqrt{(n-1)[\frac{1}{n}\{E(X-\mu)^{4} - \frac{n-3}{n-1}(\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2}(\theta + r)^{2}})^{2}\}]^{3/2}}$$

$$CL = \frac{r^2\theta^2 + 4r\theta + 2}{\theta(r\theta + 1)^2}$$

$$LCL = \frac{r^{2}\theta^{2} + 4r\theta + 2}{\theta(r\theta + 1)^{2}} + \left[-L + c_{4}^{*}(s^{2})\right]\sqrt{(n-1)\left[\frac{1}{n}\left\{E(X-\mu)^{4} - \frac{n-3}{n-1}\left(\frac{\theta^{2} + 4\theta r + 2r^{2}}{\theta^{2}(\theta + r)^{2}}\right)^{2}\right]^{3/2}}$$

Example of Control Charts for the 2nd **Two-parameter Lindley Distribution**

- simulated data
- 30 samples of 5 observations
- data from a 2nd two-parameter Lindley distribution with θ = 5 and r = 6 (15 samples of 5 observations)
- a change in the process mean of 1σ (15 samples of 5 observations) due to a shift either in θ or in r



Fig. 13: Shewhart-type control chart limits based on a 2nd two-parameter Lindley(5,6) distribution and plotted data from Lomax distributions





Fig. 10: Shewhart-type control chart for the process mean for a change in θ



Fig. 11: Shewhart-type control chart for the process variability for a change in θ

Sensitivity of The 2nd Two-parameter **Lindley Control Charts**



Fig. 12: Probability density function of the 2nd two-parameter Lindley(5,6) distribution and various Lomax distributions



for the mean of a process with control

Fig. 14: Shewhart-type control chart for the variability of a process with control limits based on a 2nd two-parameter Lindley(5,6) distribution and plotted data from Lomax distributions

Parameter Estimation

- solve equation $(2-k)b^2 + 4(2-k)b + 2(3-2k) = 0$
- k estimated using first and second

sample moments about origin: $k = \frac{m'_2}{T^2}$

$$\hat{r} = \frac{b}{\hat{\theta}} = \frac{b(b+1)\overline{X}}{b+2} \qquad \hat{\theta} = \frac{b+2}{(b+1)\overline{X}}$$

 control limits constructed by replacing θ and r with their estimators

Real Data Example

Waiting times [Ghitany et al. (2008), Shanker et al. (2013)]





the process mean

Fig. 16: Shewhart-type control chart for the process variability

References

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- [4] M. E. Ghitany, B. Atieh, and S. Nadarajah. Lindley distribution and its application, Mathematics and Computers in Simulation, 78:493-506, 2008.